Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
09/955,146	TERASAKI, HIROSHI	
Examiner	Art Unit	
Ashutosh Upreti	2623	

SEARCHED					
Class	Subclass	Date	Examiner		
382	100, 298, 299, 240, 302, 305, 232	09/24/04	A.4.		
709	203	9/29/64	A.U.		
705	57	9/29/64	A·u.		
713	176	9/29/64	A.U.		
updated	search	04/21/05	AU.		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
382	299,249,302, 305,232	04/21/05	Au	
709	203	04/21/05	AY	
705	57	04/21/05	AY	
713	176	04/21/05	Au	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
•	DATE	EXMR	
Talked to Jon Chang: Search: 382/100, 298,299 + IEEE (NPL)	9/29/04	A4.	
Talked to Andy Johns: Search: 382/100,232 709,713/176 705	9/29/04	A.u.	
Talked to Wenpeng then Search: 382/240,302,305 709	9/29/04	A.u.	
STIC Searched NPL for watermark in lowres- olution & part of high resolution image	10/26/04	A.u.	
STIC searched for: output of high resolution data if watermark detected, else output of low resolution data	11/03/ец	Ā·u.	
conducted search in EAST-see search history (including EPO, JPO, Derwent)	11/22/04	A·U.	
Searched IEEE Xplore for "watermark (and) repolation"	11/22/04	A·u.	